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5	17443	decod\$3 same (ECC or (error adj2 correct\$4) or FEC or (forward adj2 error adj2 correct\$))	USPAT; EPO; JPO; DERWENT	2004/10/26 11:28
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11	17	(decod\$3 same (ECC or (error adj2 correct\$4) or FEC or (forward adj2 error adj2 correct\$)) same (syndrome near2 generat\$4)) and (scrambl\$4 or de-scrambl\$4) and parity	USPAT; EPO; JPO; DERWENT	2004/10/26 11:31
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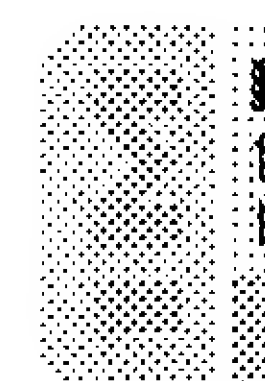
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Pages:2818 - 2823[\[Abstract\]](#)   [\[PDF Full-Text \(240 KB\)\]](#)   **IEEE JNL****3 Subspace-Based Error and Erasure Correction with DFT Codes for Wireless Channels***Rath, G.; Guillemot, C.;*Signal Processing, IEEE Transactions on [see also Acoustics, Speech, and Signal Processing, IEEE Transactions on] , Volume: 52 , Issue: 11 , Nov. 2004  
Pages:3241 - 3252[\[Abstract\]](#)   [\[PDF Full-Text \(416 KB\)\]](#)   **IEEE JNL****4 Soft-Input Reconstruction of Binary Transmitted Quantized Overcomplete Expansions***Kliwer, J.; Mertins, A.;*Signal Processing Letters, IEEE , Volume: 11 , Issue: 11 , Nov. 2004  
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**5 Error-correction and crosstalk avoidance in DSM busses**

*Patel, K.N.; Markov, I.L.;*

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**6 Identification of traitors in algebraic-geometric traceability codes**

*Fernandez, M.; Soriano, M.;*

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*Tan, W.; Cruz, J.R.;*

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*Tojo, F.; Hirakawa, S.; Toyoda, T.; Yamagata, K.; Omura, A.; Maeji, Y.; Itoh,*  
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**9 Stray field of a pulse septum induced by eddy currents**

*Shoji, Y.; Kumagai, K.;*

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*Chingfu Lan; Tianli Chu; Narayanan, K.R.; Zixiang Xiong;*

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**11 Interpolation-free coregistration and phase-correction of airborne**

**interferograms***Prats, P.; Reigber, A.; Mallorqui, J.J.;*Geoscience and Remote Sensing Letters, IEEE , Volume: 1 , Issue: 3 , July 20  
Pages:188 - 191[\[Abstract\]](#) [\[PDF Full-Text \(240 KB\)\]](#) IEEE JNL**12 Residential microwave oven interference on Bluetooth data performance***Rondeau, T.W.; D'Souza, M.F.; Sweeney, D.G.;*Consumer Electronics, IEEE Transactions on , Volume: 50 , Issue: 3 , Aug. 20  
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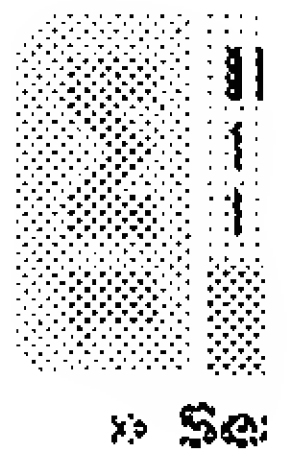
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Yanni Chen; Parhi, K.K.;

Acoustics, Speech, and Signal Processing, 2004. Proceedings. (ICASSP '04). II International Conference on , Volume: 5 , 17-21 May 2004

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